

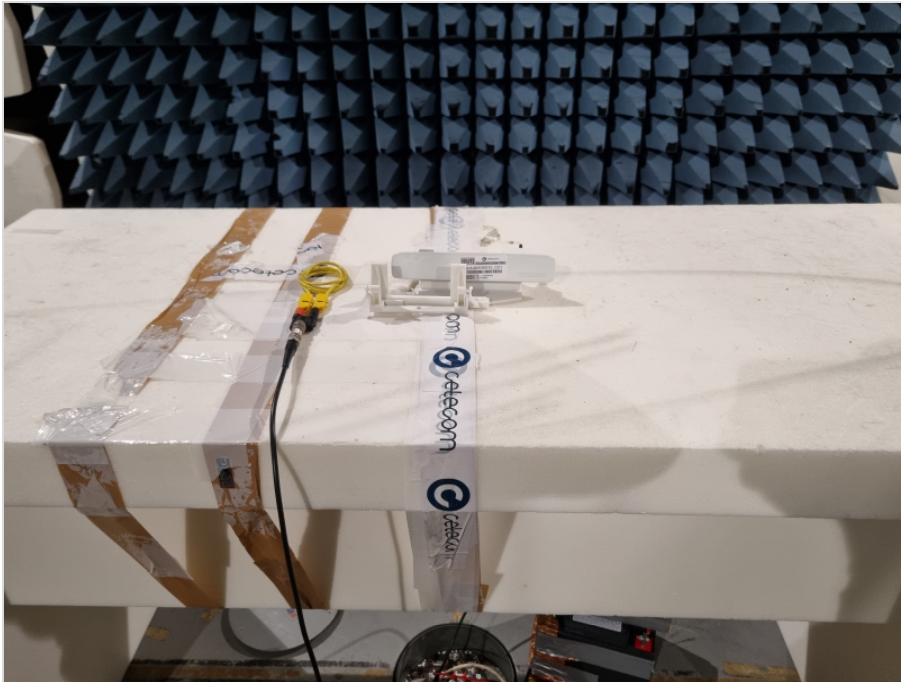
Annex 4: Test setup photographs 20-1-0063601T08a-C01-A4

Number of pages:	6	Date of Report:	2022-Jan-19
Testing company:	CETECOM GmbH Im Teelbruch 116 45219 Essen Germany Tel. + 49 (0) 20 54 / 95 19-0 Fax: + 49 (0) 20 54 / 95 19-150	Applicant:	WITTE Velbert GmbH & Co KG
Product: Model:	Automotive NFC Outer Door Handle DH421		
FCC ID:	V2T-DH421	IC:	7575A-DH421
Testing has been carried out in accordance with:	Title 47 CFR, Chapter I FCC Regulations, Subchapter A Part 15, Subpart C: §15.225 ANSI C63.10-2013 chapter 6.4/5/8/9 ISED Regulations RSS-Gen, Issue 5 + Amendment 2 RSS-210, Issue 10 Deviations, modifications or clarifications (if any) to above mentioned documents are written in each section under "Test method and limit".		

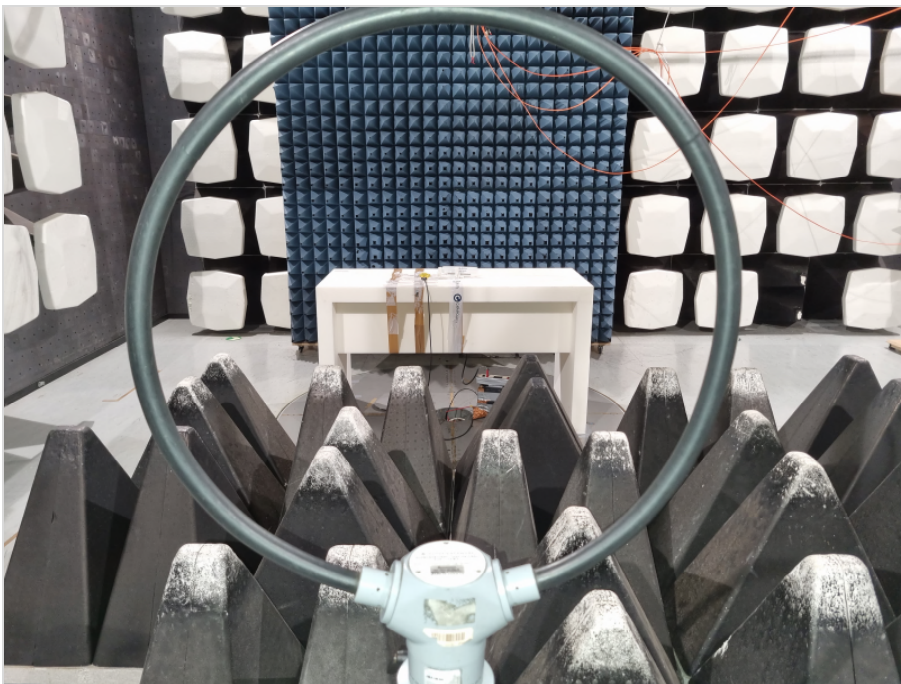
Table of Contents

1	Test setup photographs.....	3
	Photograph 1 : EUT test setup in the semi anechoic chamber, close up view_EUT elevation 0°, EUT in TX mode.....	3
	Photograph 2 : EUT test setup in the semi anechoic chamber, overview_EUT elevation 0°, EUT in TX mode.....	3
	Photograph 3 : EUT test setup in the semi anechoic chamber, close up view_EUT elevation 90°, EUT in TX mode.....	4
	Photograph 4 : EUT test setup in the semi anechoic chamber, overview_EUT elevation 0°, EUT in TXRX mode.....	4
	Photograph 5 : EUT test setup in the semi anechoic chamber, close up view_EUT elevation 0°, EUT in TXRX mode.....	5
	Photograph 6 : EUT test setup in the semi anechoic chamber, overview_EUT elevation 0°, EUT in TXRX mode.....	5
	Photograph 7 : EUT setup in the climatic chamber for test under extreme conditions, overview, EUT in TX mode.....	6
	Photograph 8 : EUT setup in the climatic chamber for test under extreme conditions, overview, EUT in TXRX mode	6

1 Test setup photographs



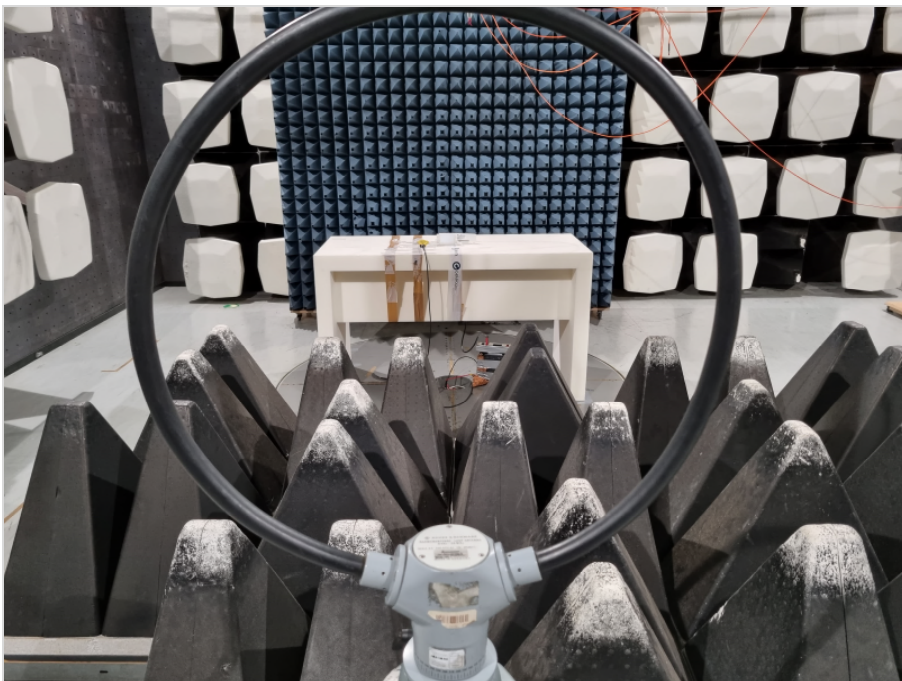
Photograph 1: EUT test setup in the semi anechoic chamber, close up view_EUT elevation 0°, EUT in TX mode



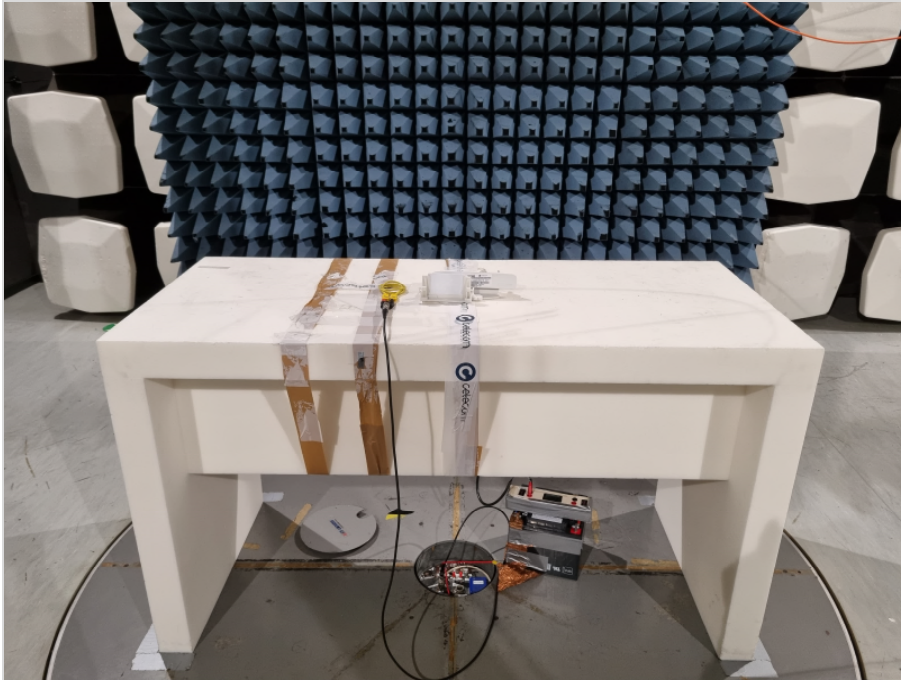
Photograph 2: EUT test setup in the semi anechoic chamber, overview_EUT elevation 0°, EUT in TX mode



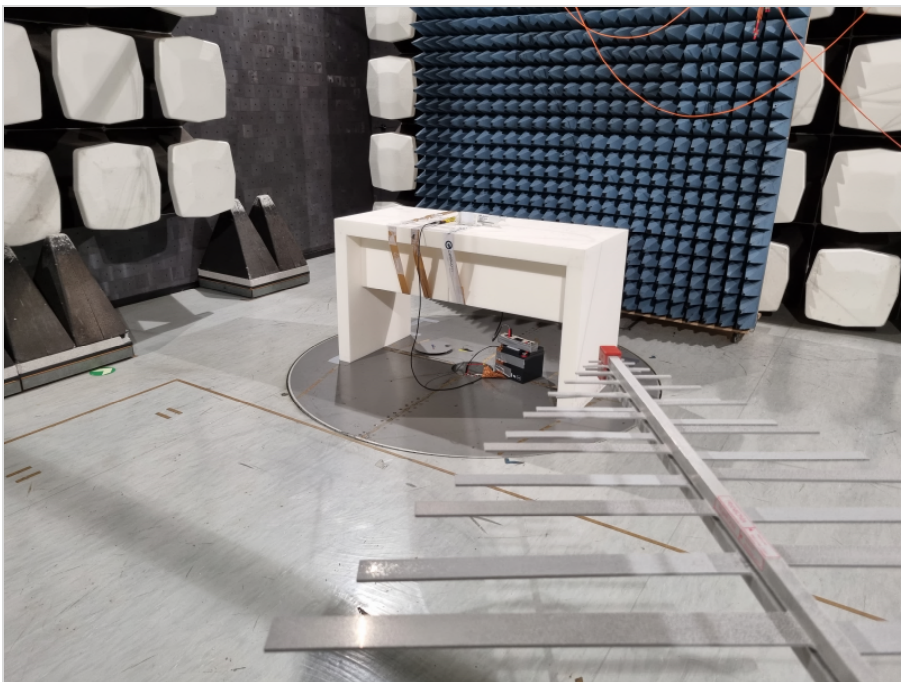
Photograph 3: EUT test setup in the semi anechoic chamber, close up view_EUT elevation 90°, EUT in TX mode



Photograph 4: EUT test setup in the semi anechoic chamber, overview_EUT elevation 0°, EUT in TXRX mode



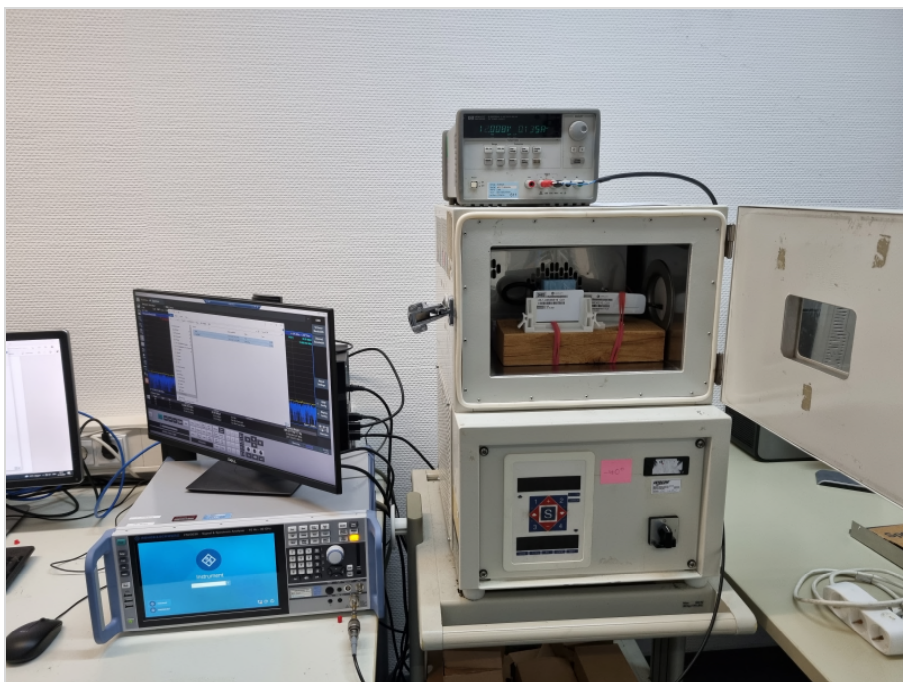
Photograph 5: EUT test setup in the semi anechoic chamber, close up view_EUT elevation 0°, EUT in TXRX mode



Photograph 6: EUT test setup in the semi anechoic chamber, overview_EUT elevation 0°, EUT in TXRX mode



Photograph 7: EUT setup in the climatic chamber for test under extreme conditions, overview, EUT in TX mode



Photograph 8: EUT setup in the climatic chamber for test under extreme conditions, overview, EUT in TXRX mode

End Of Annex 4